Notice of References Cited					Application/Control No. 09/884,875		Reexaminat	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
					Examiner		Art Unit		
					Gerald G Le	ffers Jr., PhD	1636	Page 1 of 1	
				U.S. P	ATENT DOCUM	IENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name Classification					
	Α	US-6,242,253 B1	06-2001	Karin e	t al.		435/325		
	В	US-							
	С	US-							
	D	US-							
	E	US-							
	F	US-							
	G	US-							
	Н	US-							
	ı	US-							
	J	US-				-			
	К	US-					,		
	L	US-							
	М	US-							
FOREIGN PATENT DOCUMENTS									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	(	Country Na		me	Classification	
	N								
	0								
	Р				<del></del>				
	Q								
	R								
	s	· · · · · · · · · · · · · · · · · · ·							
	Т		<u> </u>						
	NON-PATENT DOCUMENTS								
*	-	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	υ	Traenckner, et al. The EMBO Journal, Vol. 13, No. 22, pages 5433-5441, 1994.							
	>	Stended & high f 4/4/04							
	w			V.					
	х								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.